



Muon Identification and Isolation efficiencies on Run II data with the CMS experiment



Poster 85: **Pedro J. Fernández Manteca** (IFCA: Universidad de Cantabria - CSIC) on behalf of the CMS collaboration

The Tag-and-Probe method (I)

- Total muon detection efficiency:

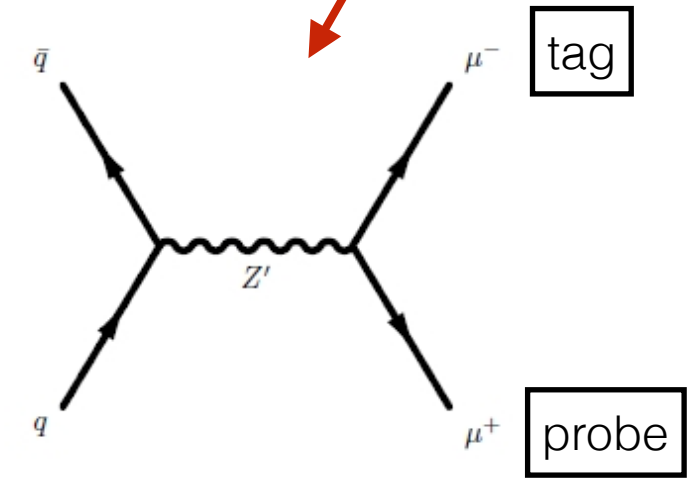
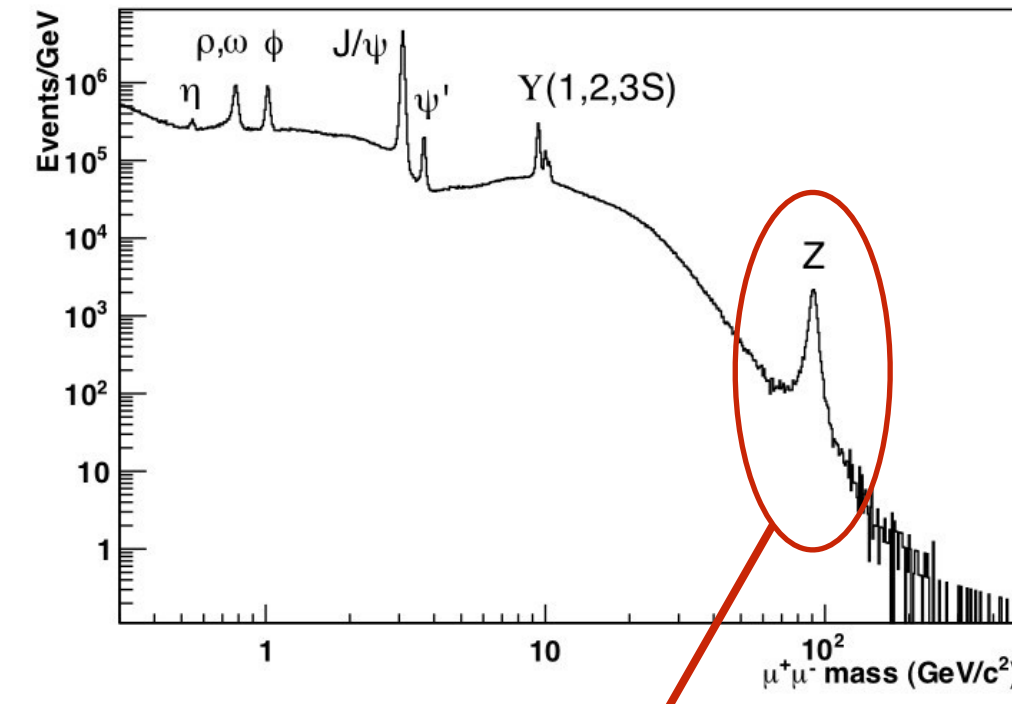
$$\mathcal{E}_{total} = \mathcal{E}_{trk} \times \mathcal{E}_{ID} \times \mathcal{E}_{ISO} \times \mathcal{E}_{trigger}$$

- Tag & Probe** method: A known resonance is considered → in this case the invariant mass of two muons that come from Z. We name one muon as "tag" and the other as "probe"

- "tag" muons: they pass very tight requirements of ID and ISO
- "probe" muons: compatible tracks with the Z resonance

- The aim is to measure a certain ID or ISO efficiency over the "probe" muons as:

$$\mathcal{E} = \frac{N_{pass}}{N_{all}}$$



The Tag-and-Probe method (II)

- As the selected events may not come from the resonance → There could be a bias in the efficiency measurement

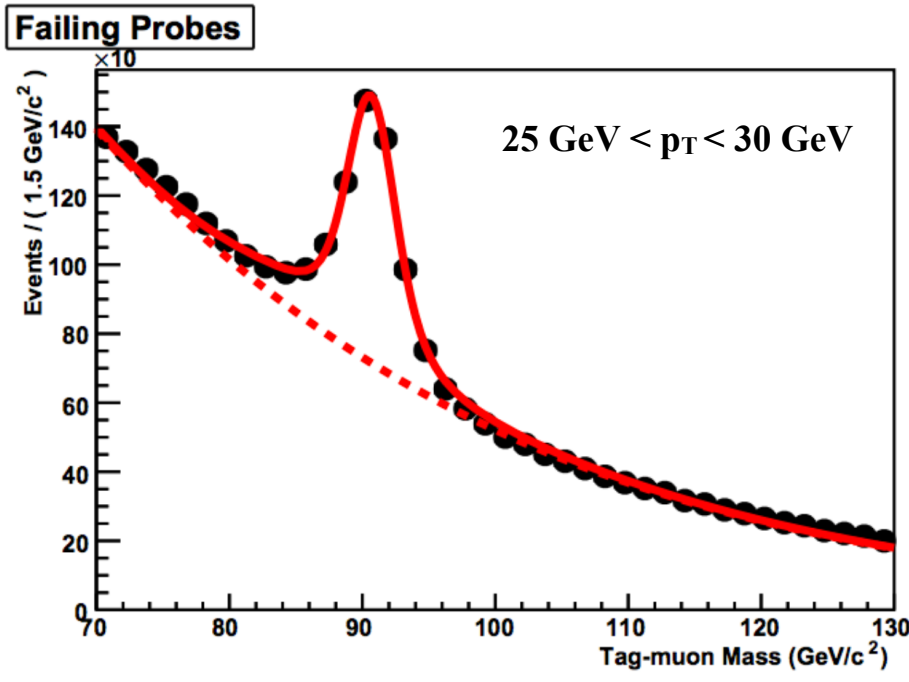
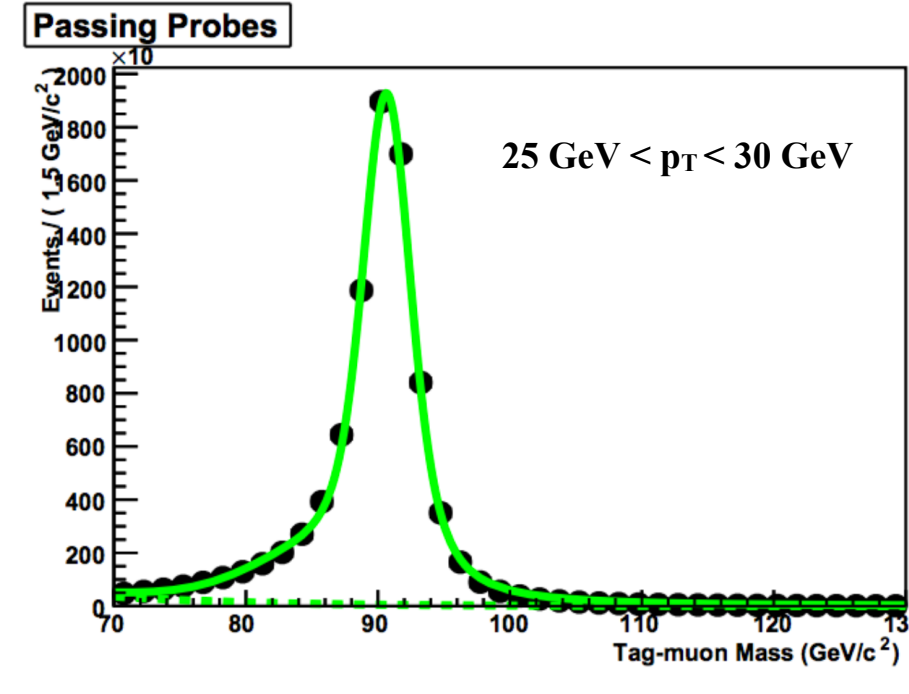
- To avoid this we do a simultaneous fit to the signal (Z peak) and the background → A wider mass range (for instance 70-130 GeV) has to be considered in order to be able to fit the background properly.

- The total probes sample is split considering whether the muons pass (**Passing probes**) or do not pass (**Failing probes**) the ID / ISO working point that we want to measure.

- The fit is done for the passing probes, for the failing probes and for all probes. Then the efficiency is computed as:

$$\mathcal{E} = \frac{\text{passing probes}}{\text{passing probes} + \text{failing probes}} \quad \text{The same procedure is followed for simulation}$$

- If we want to measure the efficiency as function of one kinematic variable, this selection will have to be repeated for each variable bin



Data / Monte-Carlo samples and event selection

- Data sample:

- Collision data at 13 TeV and 25 ns bunch spacing. Luminosity: 36 fb⁻¹

- Monte-Carlo sample:

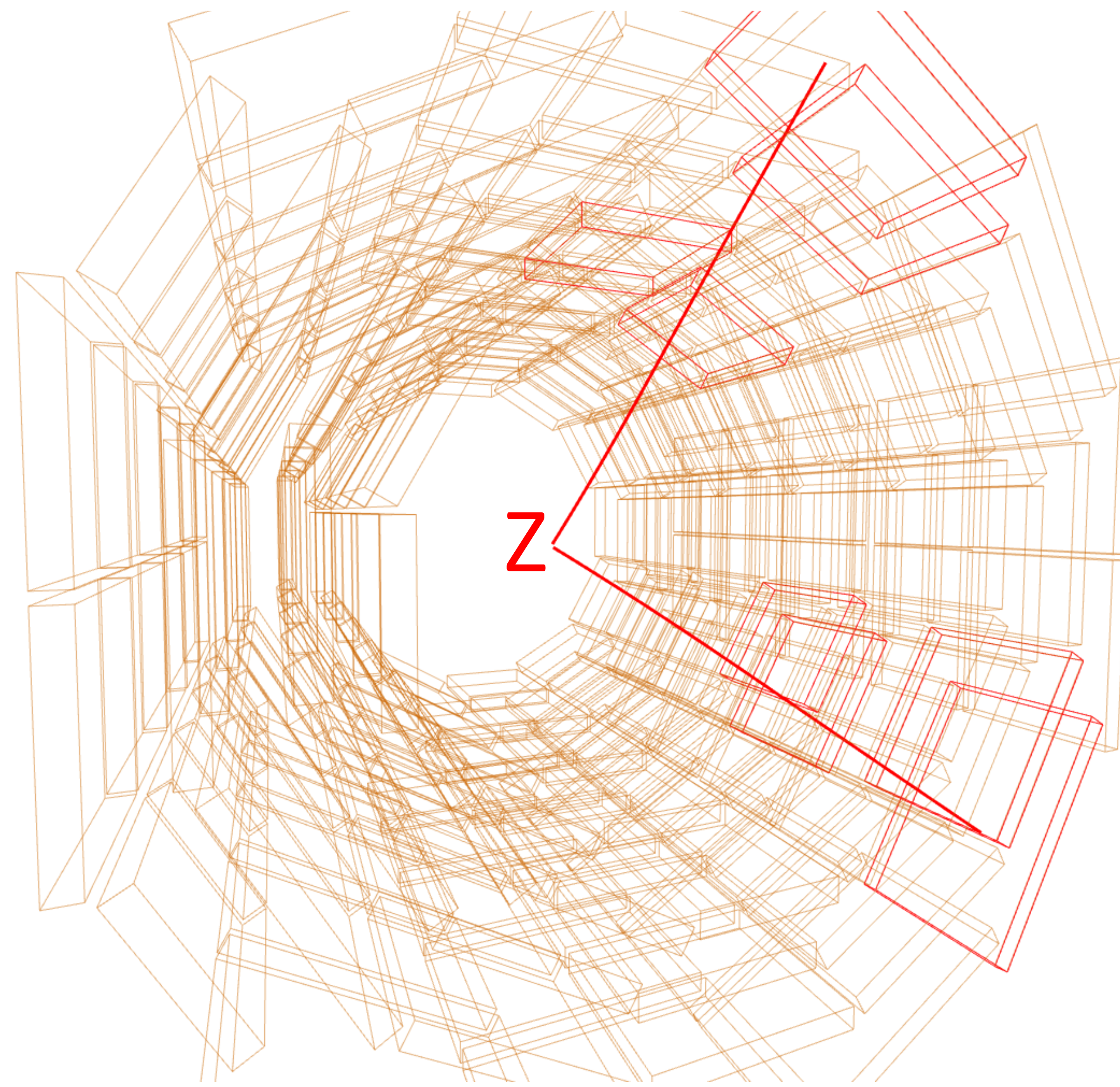
- Drell-Yan + Jets sample generated with M5_aMC@NLO at LO
- Re-weighting is applied to match the pileup distribution in data

- Fitting parameters:

- Mass window: [70-130 GeV] for ID, [77-130 GeV] for ISO

- Functions:

- For ID as function of p_T → **Signal**: sum of two voigtians; **Background**: product of failing exponential and error function
- Else → **Signal**: sum of two voigtians. **Background**: Exponential



- Probe muon selection:**

- For ID efficiencies:
 - Compatible tracks with the Z resonance
 - p_T > 20 GeV
- For ISO efficiencies:
 - Pass a required ID working point
 - p_T > 20 GeV

- Tag muon selection:**

- Tight muon identification
- SingleMuon p_T > 24 trigger that includes a relative isolation requirement (Iso < 0.15)
- p_T > 26 GeV
- Relative Isolation(ΔR=0.4) < 0.2



- The efficiency is computed for several working points based on quality requirements on the muon ID and ISO (more details in [arXiv:1804.04528](https://arxiv.org/abs/1804.04528))

- Tight muon ID** aims to suppress muons from decay in flight and from hadronic punch-through

- Relative muon Isolation**: sum of the energy relative to the muon p_T in a geometrical cone ΔR surrounding it

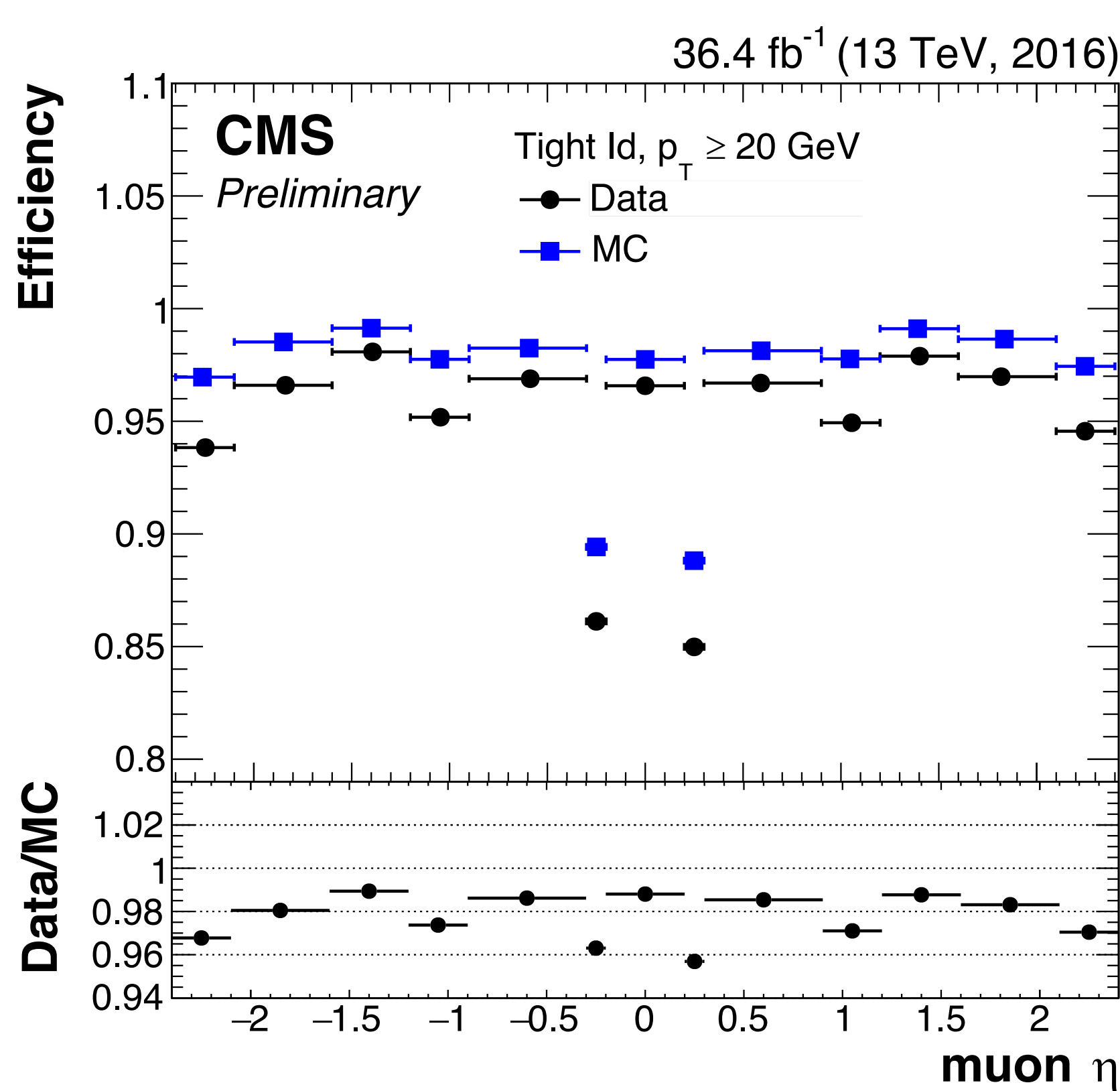
- Tight muon ISO**: relative isolation (ΔR=0.4) < 0.15

- The systematic uncertainty effect on the measurements can be evaluated by varying the tag muon definition, the fit functions, the number of mass bins, or the mass range where the fits are performed

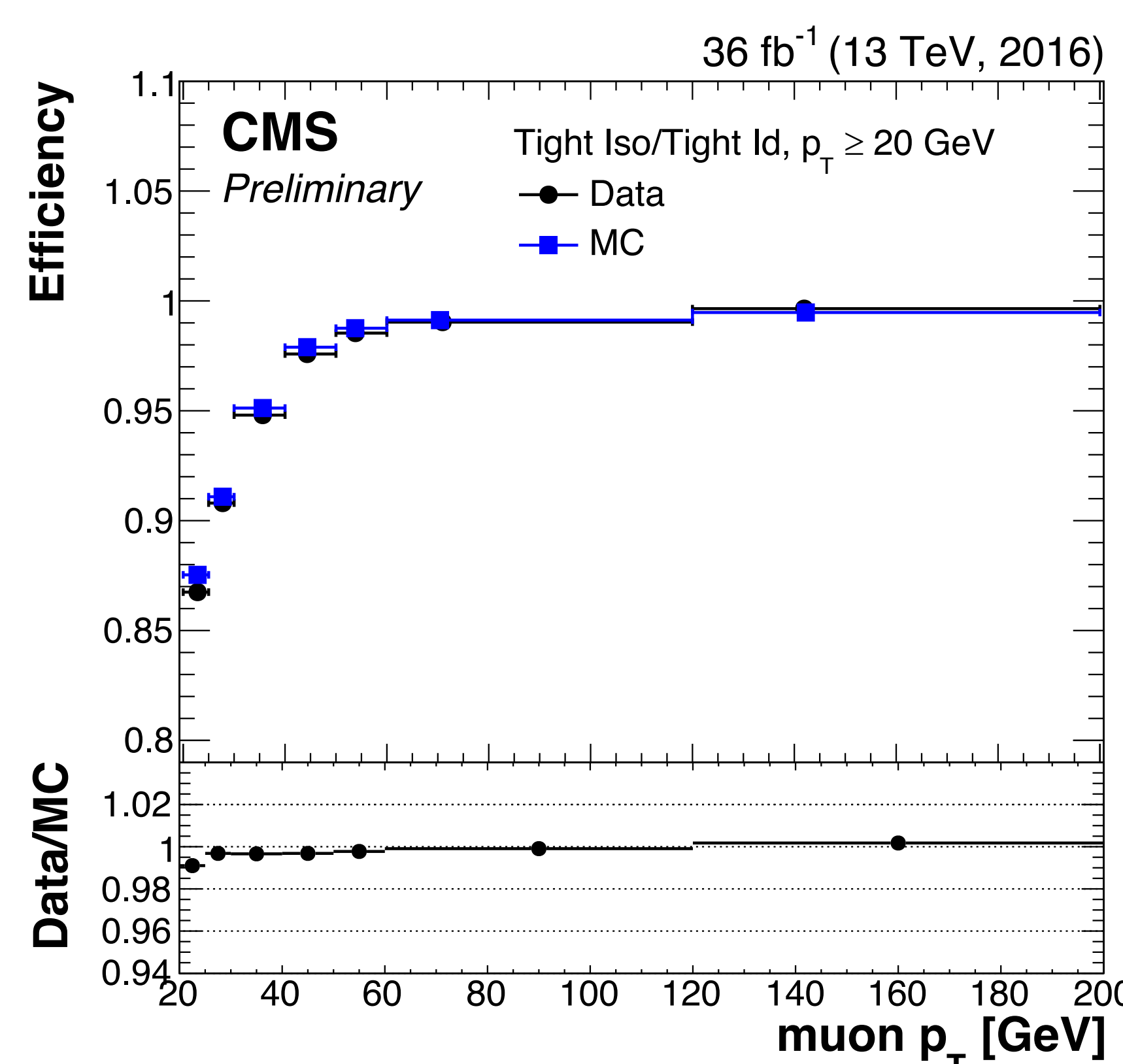
- The impact of the variations on top of the efficiencies is in most of the cases less than 0.5 %

Results

Tight ID vs η



Tight ISO vs p_T



Working Point	Global efficiency
Loose ID	~ 99%
Medium ID	~ 97%
Tight ID	~ 96%
High-p _T ID	~ 96%
Loose ISO / Loose ID	~ 99%
Loose ISO / Medium ID	~ 99%
Loose ISO / Tight ID	~ 99%
Loose Trk ISO / High-p _T ID	~ 98%
Tight ISO / Medium ID	~ 96%
Tight ISO / Tight ID	~ 96%